## Notice of References Cited Application/Control No. 10/619,787 Examiner Aditya S Bhat Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0121094 A1	09-2002	VanHoudt, Paulus Joseph	62/3.3
	В	US-5,205,132 A	04-1993	Fu, Deng-Yuan	62/208
	С	US-6,681,073 B2	01-2004	Chan et al.	385/140
	D	US-6,353,623 B1	03-2002	Munks et al.	372/20
	Е	US-6,525,550	02-2003	Pan, Qi	324/721
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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